

<b>Notice of References Cited</b>	Application/Control No. 09/751,391		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Naeem Haq		Art Unit 3625	Page 1 of 1

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*	C	US-2002/0143614	10-2002	MacLean et al.	705/14
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